



Description

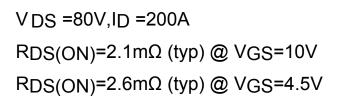
The XPX80N023LL uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

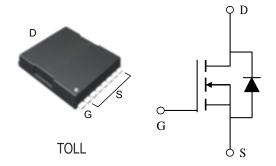
General Features

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

Application

- PWM
- Load Switching





Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
XPX80N023LL	XPX80N023LL	TOLL	-	-	2000

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	80	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	I _D	200	Α
Drain Current-Continuous(T _C =100℃)	I _D (100℃)	120	Α
Pulsed Drain Current	I _{DM}	610	Α
Maximum Power Dissipation	P _D	231	W
Derating factor		1.85	W/℃
Single pulse avalanche energy (Note 5)	Eas	552	mJ
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 175	°C
Thermal Resistance,Junction-to-Case(Note 2)	Rejc	0.68	°C/W



Electrical Characteristics (T_A = 25°C unless otherwise noted)

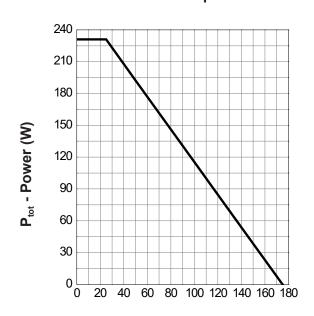
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit		
Static Ch	aracteristics							
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	80	-	-	V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =64V, V _{GS} =0V	-	-	1	μА		
		T _J =85°C	-	-	30			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{DS} = 250 \mu A$	2	3	4	V		
I _{GSS}	Gate Leakage Current	V_{GS} =±20V, V_{DS} =0V	-	-	±100	nA		
R _{DS(ON)} c	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =80A	-	2.1	2.9	mΩ		
Diode Ch	aracteristics							
V _{SD} ^c	Diode Forward Voltage	I _{SD} =40A, V _{GS} =0V	-	0.8	1.1	V		
t _{rr} d	Reverse Recovery Time	I _{SD} =80A, dI _{SD} /dt=100A/μs	-	65	-	ns		
Q_{rr}^{d}	Reverse Recovery Charge	I _{SD} -60A, αι _{SD} /αι-100A/μS	-	113	-	nC		
Dynamic	Dynamic Characteristics ^d							
R_{G}	Gate Resistance	V_{GS} =0V, V_{DS} =0V,F=1MHz	-	1	-	Ω		
C _{iss}	Input Capacitance	V _{GS} =0V,	-	5500	7150	pF		
C _{oss}	Output Capacitance	V _{DS} =50V,	-	873	-			
C_{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	117	-			
$t_{d(ON)}$	Turn-on Delay Time		-	34	61			
t _r	Turn-on Rise Time	$V_{DD} = 30V, R_{L} = 30\Omega,$	-	15	28	no		
t _{d(OFF)}	Turn-off Delay Time	I_{DS} =1A, V_{GEN} =10V, R_{G} =6 Ω	-	81	145	ns		
t _f	Turn-off Fall Time		-	156	280			
Gate Cha	rge Characteristics ^d							
Q_g	Total Gate Charge	.,		82	115			
Q_{gs}	Gate-Source Charge	V_{DS} =50V, V_{GS} =10V, I_{DS} =80A	-	30	-	nC		
Q_{gd}	Gate-Drain Charge	.08 307.	-	16	-			

Note c : Pulse test ; pulse width \leq 300 μ s, duty cycle \leq 2%. Note d : Guaranteed by design, not subject to production testing.



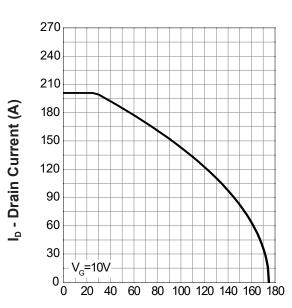
Typical Operating Characteristics

Power Dissipation



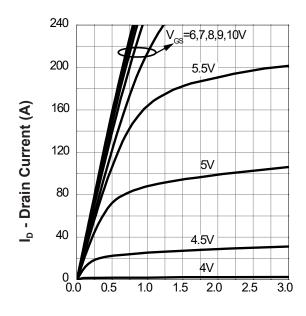
T_c - Case Temperature (°C)

Drain Current



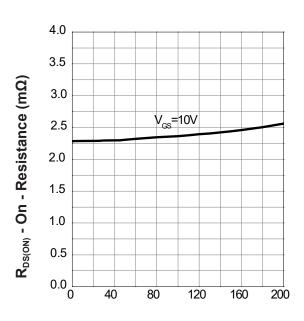
T_c - Case Temperature (°C)

Output Characteristics



V_{DS} - Drain - Source Voltage (V)

Drain-Source On Resistance

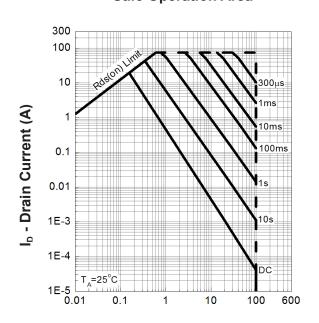


I_D - Drain Current (A)



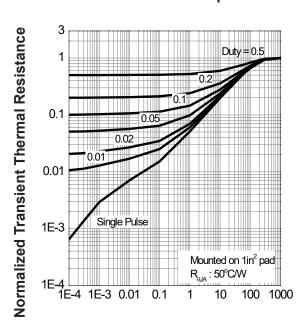
Typical Operating Characteristics(Cont.)

Safe Operation Area



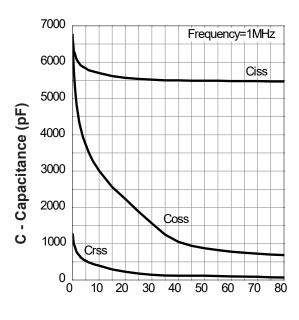
V_{DS} - Drain - Source Voltage (V)

Thermal Transient Impedance



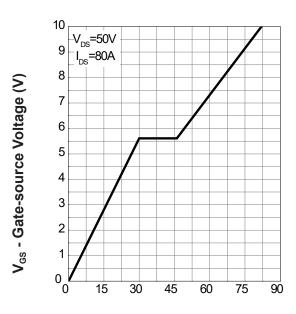
Square Wave Pulse Duration (sec)

Capacitance



V_{DS} - Drain-Source Voltage (V)

Gate Charge



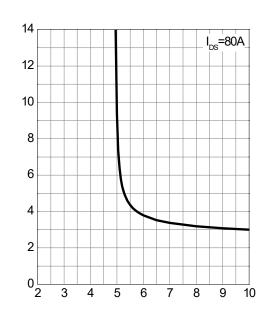
Q_G - Gate Charge (nC)



R_{DS(ON)} - On - Resistance (mΩ)

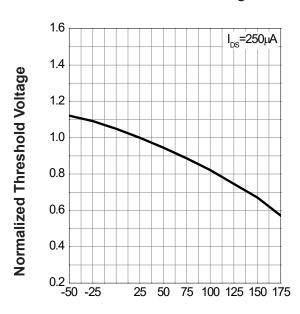
80V N-ChannelEnhancement Mode MOSFET

Gate-Source On Resistance



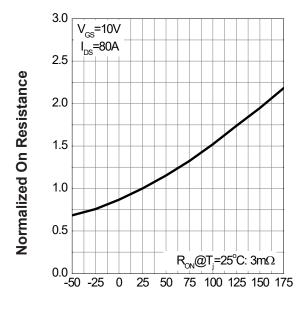
V_{GS} - Gate - Source Voltage (V)

Gate Threshold Voltage



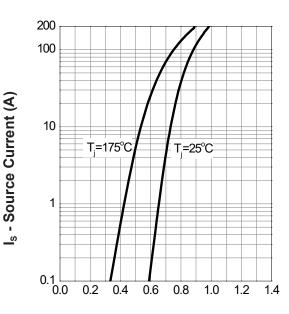
T_j - Junction Temperature (°C)

Drain-Source On Resistance



T_j - Junction Temperature (°C)

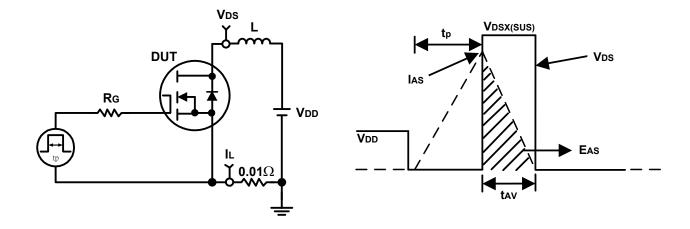
Source-Drain Diode Forward



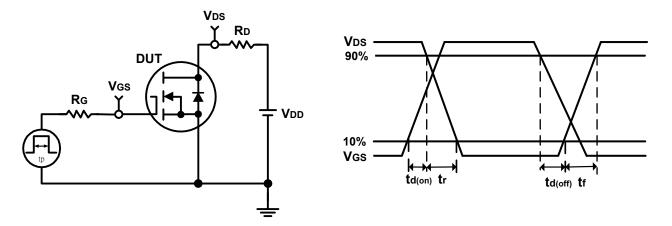
V_{SD} - Source - Drain Voltage (V)



Avalanche Test Circuit and Waveforms



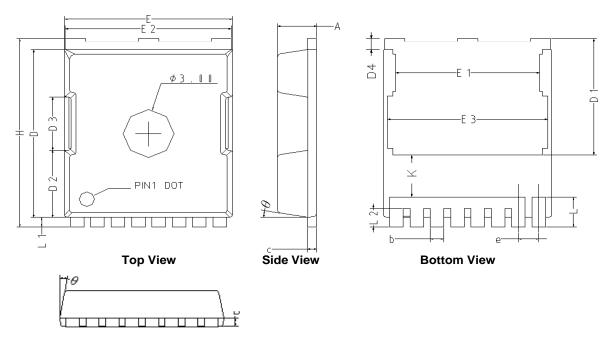
Switching Time Test Circuit and Waveforms





Package Information

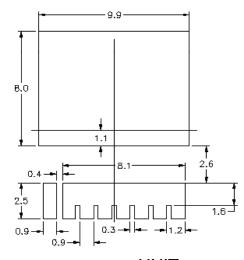
TOLL



Side View

	TO-LL				
SYMBOLS	MILLIN	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	2.20	2.40	0.087	0.094	
b	0.70	0.90	0.028	0.035	
С	0.40	0.60	0.016	0.024	
D	10.23	10.63	0.403	0.419	
D1	7.05	7.45	0.278	0.293	
D2	3.98	4.38	0.157	0.172	
D3	3.10	3.50	0.122	0.138	
D4	0.50	0.90	0.020	0.035	
E	9.70	10.10	0.382	0.398	
E1	8.30	8.70	0.327	0.343	
E2	9.60	10.00	0.378	0.394	
E3	9.26	9.66	0.365	0.380	
H	11.53	11.93	0.454	0.470	
е	1.2 BSC		0.0472 BSC		
K	2.43	2.83	0.096	0.111	
L	1.65	2.05	0.065	0.081	
L1	0.40	0.80	0.016	0.031	
L2	0.95	1.35	0.037	0.053	
θ	6°	10°	6°	10°	

RECOMMENDED LAND PATTERN



UNIT: mm



Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	245℃±5℃	5sec±1sec
Pb-Free device	260℃+0/-5℃	5sec±1sec



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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